Application/Control No.	Applicant(s)/Patent under Reexamination	
10/767,296	YAN, JOHN Y.	
Examiner	Art Unit	
salebaal Thalas	0704	

SEARCHED				
Class	Subclass	Date	Examiner	
623	1.15			
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
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